

<b>Notice of References Cited</b>	Application/Control No. 10/582,330	Applicant(s)/Patent Under Reexamination SUMIYA, HITOSHI	
	Examiner SHENG HAN DAVIS	Art Unit 1732	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0019114	01-2005	Sung, Chien-Min	407/119
	B	US-			
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